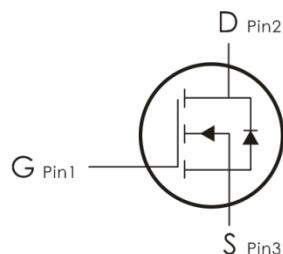
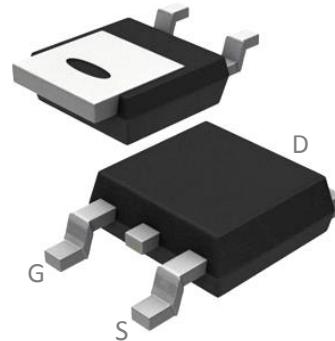


## Description:

This N-Channel MOSFET uses advanced trench technology and design to provide excellent  $R_{DS(on)}$  with low gate charge. It can be used in a wide variety of applications.



## Features:

- 1)  $V_{DS}=200V, I_D=5A, R_{DS(ON)} \leq 0.47\Omega @ V_{GS}=10V$
- 2) Low gate charge.
- 3) Green device available.
- 4) Advanced high cell density trench technology for ultra  $R_{DS(ON)}$ .
- 5) Excellent package for good heat dissipation.

## Absolute Maximum Ratings: ( $T_c=25^\circ C$ unless otherwise noted)

Symbol	Parameter	Ratings	Units
$V_{DS}$	Drain-Source Voltage	200	V
$V_{GS}$	Gate-Source Voltage	$\pm 30$	V
$I_D$	Continuous Drain Current- $T_C=25^\circ C$	5	A
	Continuous Drain Current- $T_C=100^\circ C$	3.1	
	Pulsed Drain Current	---	
$E_{AS}$	Single Pulse Avalanche Energy <sup>1</sup>	60	mJ
$P_D$	Power Dissipation( $T_c=25^\circ C$ )	32	W
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55 to +150	$^\circ C$

## Thermal Characteristics:

Symbol	Parameter	Max	Units
$R_{eJC}$	Thermal Resistance,Junction to Case	2.27	$^\circ C/W$
$R_{eJA}$	Thermal Resistance,Junction to Ambient	110	

**Electrical Characteristics:** ( $T_C=25^\circ C$  unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>Off Characteristics</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250 \mu A$	200	---	---	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{GS}=0V, V_{DS}=200V$	---	---	1	$\mu A$
$I_{GSS}$	Gate-Source Leakage Current	$V_{GS}=\pm 30V, V_{DS}=0A$	---	---	$\pm 100$	nA
<b>On Characteristics</b>						
$V_{GS(th)}$	GATE-Source Threshold Voltage	$V_{GS}=V_{DS}, I_D=250 \mu A$	2	---	4	V
$R_{DS(ON)}$	Drain-Source On Resistance	$V_{GS}=10V, I_D=2.5A$	---	---	0.47	$\Omega$
<b>Dynamic Characteristics</b>						
$C_{iss}$	Input Capacitance	$V_{DS}=25V, V_{GS}=0V, f=1MHz$	---	210	270	pF
$C_{oss}$	Output Capacitance		---	40	50	
$C_{rss}$	Reverse Transfer Capacitance		---	6	8	
<b>Switching Characteristics</b>						
$t_{d(on)}$	Turn-On Delay Time <sup>3,4</sup>	$V_{DS}=250V, I_D=5A,$ $R_{GEN}=25 \Omega$	---	7	25	ns
$t_r$	Rise Time <sup>3,4</sup>		---	55	120	ns
$t_{d(off)}$	Turn-Off Delay Time <sup>3,4</sup>		---	9	30	ns
$t_f$	Fall Time <sup>3,4</sup>		---	25	60	ns
$Q_g$	Total Gate Charge <sup>3,4</sup>	$V_{GS}=10V, V_{DS}=400V,$ $I_D=5A$	---	6	7.5	nC
$Q_{gs}$	Gate-Source Charge <sup>3,4</sup>		---	1.5	---	nC
$Q_{gd}$	Gate-Drain "Miller" Charge <sup>3,4</sup>		---	2.2	---	nC
<b>Drain-Source Diode Characteristics</b>						
$V_{SD}$	Source-Drain Diode Forward Voltage	$V_{GS}=0V, I_D=5A$	---	---	1.5	V

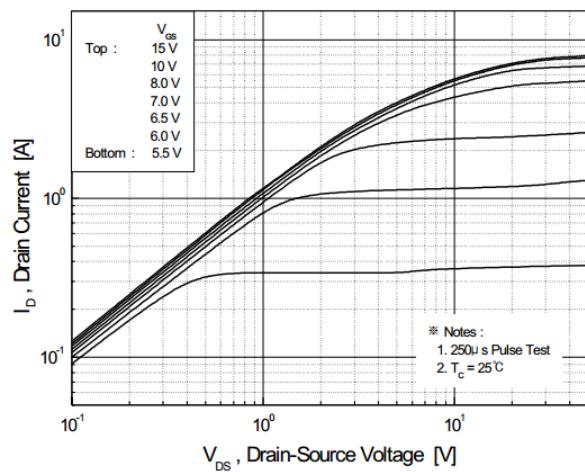
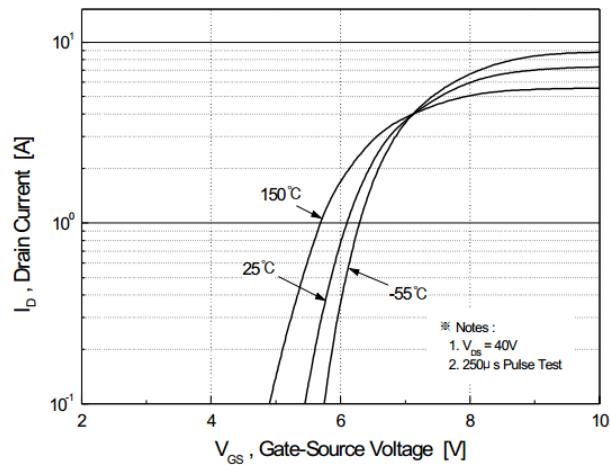
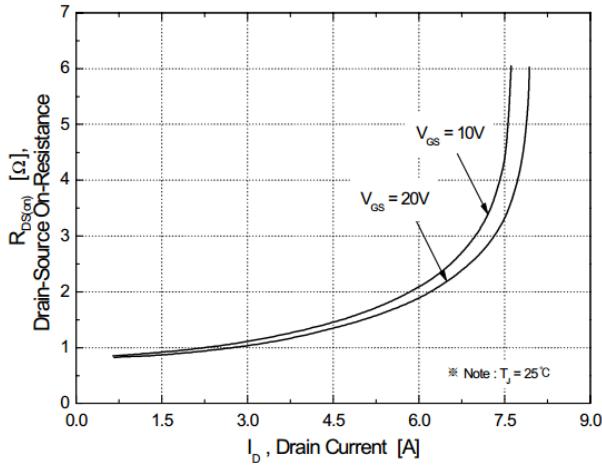
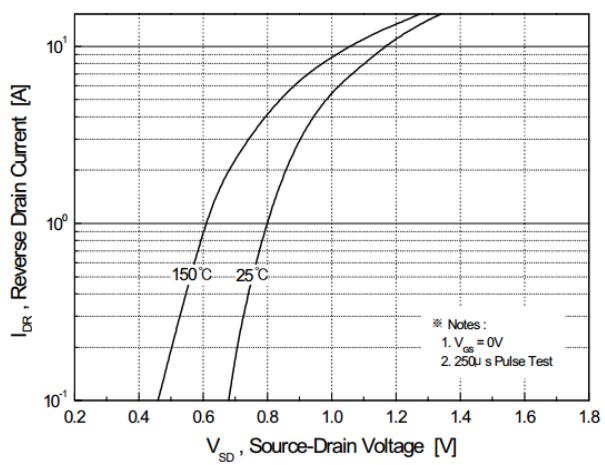
**Notes:**

1, L=3.0mH, IAS=5A, VDD=50V, RG=25Ω, Starting TJ =25°C

2, Repetitive Rating : Pulse width limited by maximum junction temperature

3, Pulse Test : Pulse Width  $\leq 300 \mu s$ , Duty Cycle  $\leq 2\%$

4, Essentially Independent of Operating Temperature.

**Typical Characteristics:** (T<sub>C</sub>=25°C unless otherwise noted)

**Figure 1. On-Region Characteristics**

**Figure 2. Transfer Characteristics**

**Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage**

**Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature**

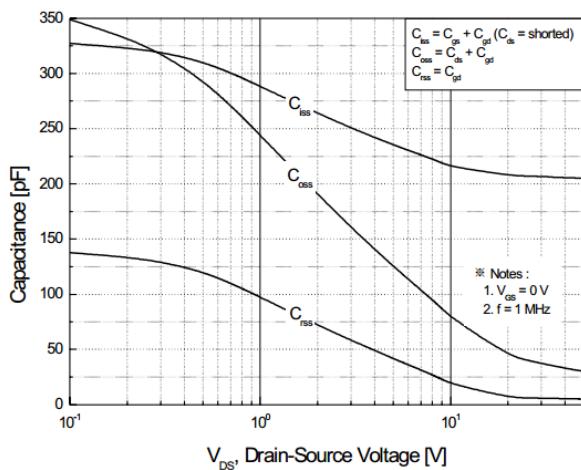


Figure 5. Capacitance Characteristics

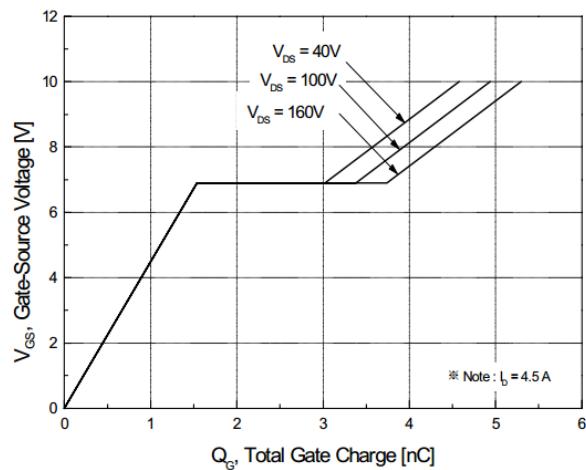


Figure 6. Gate Charge Characteristics

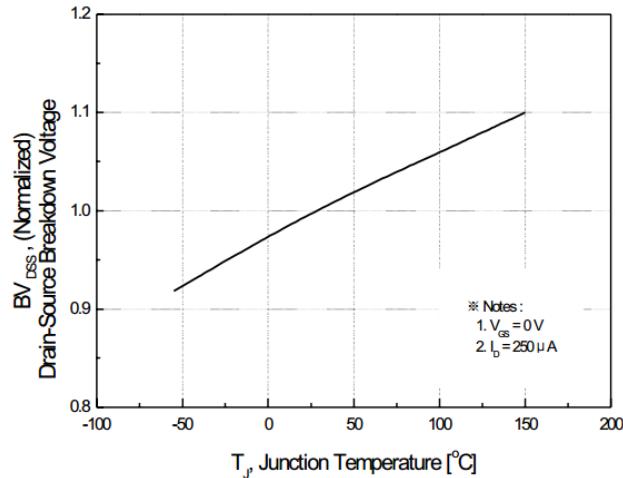


Figure 7. Breakdown Voltage Variation vs. Temperature

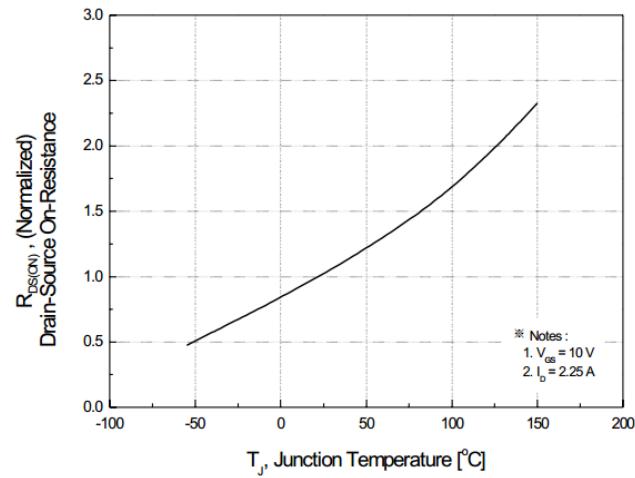


Figure 8. On-Resistance Variation vs. Temperature

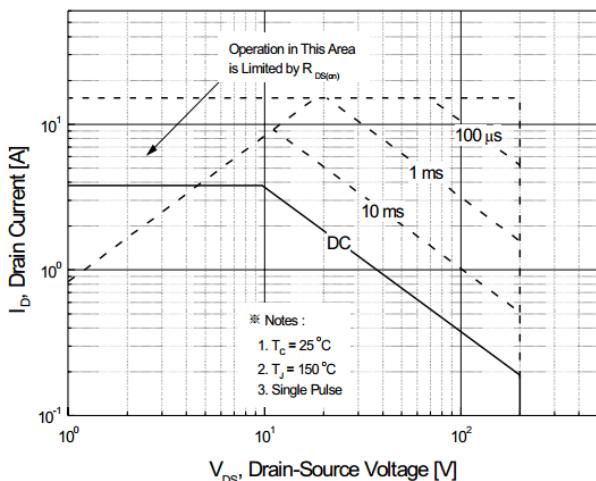


Figure 9. Maximum Safe Operating Area

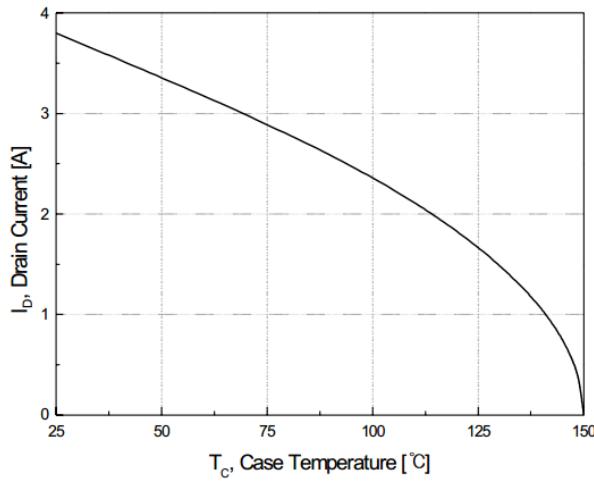
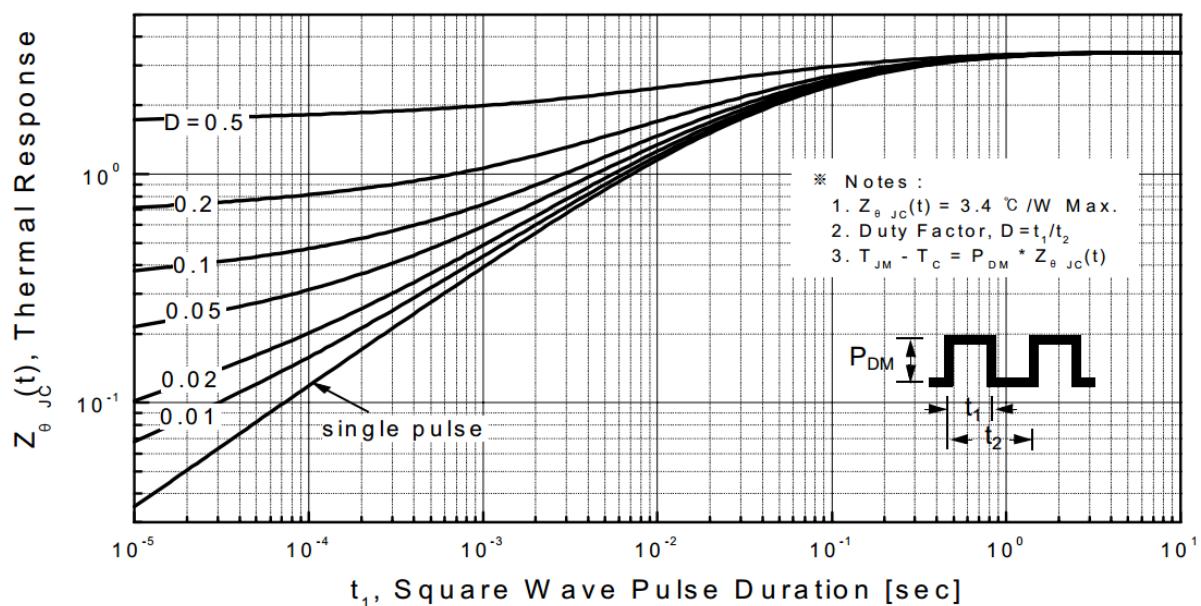


Figure 10. Maximum Drain Current vs. Case Temperature



**Figure 11. Transient Thermal Response Curve**



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